

Form PTO 1449
(Modified)OCT 22 2002
U.S. DEPARTMENT OF COMMERCE
PATENT & TRADEMARK OFFICEU.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

219491US3

SERIAL NO.

10/073,910

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Yoshinobu TAKANOFILING DATE
February 14, 2002GROUP
2874

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
W	AA	5,963,699	10/05/99	T. TANAKA, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
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	AL						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	YES	NO
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AW	
AX	
AY	
AZ	

 Additional References sheet(s) attached

Examiner

Hemant Singhvi

Date Considered

3/4/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 219491US3	SERIAL NO. 10/073,910
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Yoshinobu TANAKO		
		FILING DATE 02/14/02	GROUP 2874	
U.S. PATENT DOCUMENTS				
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS
m AA	5,783,636	07/21/98	KOIKE, et al.	
m AB	5,760,139	06/02/98	KOIKE, et al.	
m AC	6,271,312	08/08/01	KOIKE, et al.	
m AD	5,916,971	05/29/99	KOIKE, et al.	
m AE	6,071,441	06/06/00	KOGANEZAWA, et al.	
m AF	6,074,511	06/13/00	TAKANO, et al.	
m AG	6,225,382	05/01/01	MATSUKURA, et al.	
m AH	6,166,125	12/27/00	SUGIYAMA, et al.	
m AI	6,111,062	08/29/00	SHIROTA, et al.	
m AJ	6,221,987	04/24/01	SUGIYAMA	
m AK	6,448,452	09/10/02	KASHIWAGI, et al.	
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FOREIGN PATENT DOCUMENTS				
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
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Examiner	<i>Hemang Singhani</i>			Date Considered <i>3/04/04</i>
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.				

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshinobu TAKANO			
				FILING DATE February 14, 2002	GROUP 2874		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>hs</i>	AA	4,629,284	12/16/86	F.-L. MALAVILLE			
<i>hs</i>	AB	4,871,227	10/03/89	W. TILSE			
<i>hs</i>	AC	5,195,153	03/16/93	L. FINZEL			
<i>hs</i>	AD	4,779,954	10/25/88	Y. TATSUKAMI, et al.			
<i>hs</i>	AE	5,692,089	11/25/97	G. J. SELLERS			
	AF						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
YES	NO						
<i>hs</i>	AO	0 065 096	11/24/82	EUROPE			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner	<i>Hemant Sangheri</i>				Date Considered <i>3/4/04</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							